Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/696,776	HUITEMA, CHRISTIAN	
Examiner	Art Unit	

2616

Raj K. Jain

SEARCHED					
Class	Subclass	Date	Examiner		
			<u> </u>		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
Interferen	ce search	4/29/2007	RJ	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
USPGPUB, USPAT	4/25/2007	RJ		
370/241.1,242,254,255,256 TEXT SEARCH.	4/25/2007	RJ		
711/118-130 TEXT SEARCH	4/25/2007	RJ		
Inventor search	4/29/2007	RJ		
Updated search	4/29/2007	КJ		
